

Notice of References Cited	Application/Control No. 10/764,483		Applicant(s)/Patent Under Reexamination LEE, GUN-IL	
	Examiner Allen H. Nguyen		Art Unit 2625	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,385,728	05-2002	DeBry, Roger K.	726/9
*	B	US-2003/0002072	01-2003	Berkema et al.	358/1.15
*	C	US-5,727,890	03-1998	Stodder et al.	400/624
*	D	US-2002/0016833	02-2002	Yajima et al.	709/220
*	E	US-2002/0024684	02-2002	Tanimoto, Yoshifumi	358/400
*	F	US-7,268,899	09-2007	Crumly, James D.	358/1.14
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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